

Search Notes

Application/Control No.

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Examiner

Hien Tran

Applicant(s)/Patent under
Reexamination

HIRAMATSU ET AL.

Art Unit

1764

SEARCHED

Class	Subclass	Date	Examiner
422	170-171, 173,177, 180,211, 222	1/17/2003	HT
60	297,299,	1/17/2003	HT
60	300	1/17/2003	HT
updated	search	6/29/2003	HT
updated	search	10/13/2004	HT
updated	search	11/15/2004	HT
updated	search	5/25/2005	HT
updated	search	1/26/2006	HT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
checked parent application 08/726,468	1/17/2003	HT
East Image class/subclass search / Inventors' names search	10/13/2004	HT